

**Notice of References Cited**

Application/Control No.

1

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

2615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,904,783	06-2005	Elenich et al.	73/1.73
*	B	US-6,144,658	11-2000	Lebizay et al.	370/352
*	C	US-5,347,499	09-1994	Woo, Tae-jin	369/4
*	D	US-6,377,862	04-2002	Naruki et al.	700/94
*	E	US-2003/0137341	07-2003	LeChevalier, Robert	327/536
*	F	US-6,076,504	06-2000	Stavnheim et al.	123/447
*	G	US-4,425,628	01-1984	Bedard et al.	710/8
*	H	US-6,819,407	11-2004	Arita et al.	356/4.01
*	I	US-5,878,098	03-1999	Wang et al.	375/377
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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